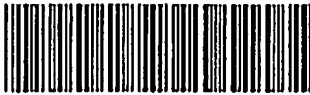


Search Notes



Application/Control No.

10/071,645

Examiner

Jon M. Lockard

Applicant(s)/Patent under Reexamination

BIHAIN ET AL.

Art Unit

1647

SEARCHED

Class	Subclass	Date	Examiner
530	350	7/30/2004	JML
514	12	7/30/2004	JML
435	7.1	7/30/2004	JML
435	69.1	7/30/2004	JML
Updated		4/24/2005	JML
NONE		3/31/06	JML

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
East Search, US PAT, US PG-PUB, Seq. Attached Search History		12/20/2006	JML
PALM: Inventor Search		12/20/2006	JML
STIC Search of SEQ ID NO: 1-5; Results in SCORP		10/28/2006	JML

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
STIC Sequence Search of Commercial and Patent Databases: See Attached Search Report	5/11/2004	JML
STIC Sequence Search of SEQ ID NO:1 Against Commercial and Patent Databases, Word Size = 20: See Attached Search Report.	7/7/2004	JML
East Search: text and Inventor's Name Search. See Attached Search Report.	7/30/2004	JML
PALM: Inventor's Name Search.	7/30/2004	JML
Updated	4/24/2005	JML
STIC Sequence Search of Commercial and Patent Databases: See Attached Search Report	3/30/2005	JML
STIC Search of Commercial and Patent Databases: See Attached	3/31/06	JML
PALM: Inventor Search	3/31/06	JML
East (US PAT, US PG-PUB, EPO, Derwent): See Attached Search History	3/31/06	JML
STN (MEDLINE, SCISEARCH, EMBASE, BIOSIS); see Attached Search History	3/31/06	JML
Consulted Y. Eyley on genomic seq.	12/18/2006	JML